High-Speed

## FEATURES

1000 MHz Toggle Rate
Driver/Comparator/Active Load and Dynamic Clamp Included
Inhibit Mode Function
100-Lead LQFP Package with Built-In Heat Sink

## Driver

$48 \Omega$ Output Resistance
800 ps Tr/Tf for a 3 V Step
Comparator
1.1 ns Propagation Delay at 3 V

Load
$\pm 40 \mathrm{~mA}$ Voltage Programmable Current Range 50 ns Settling Time to $\mathbf{1 5 ~ m V}$
APPLICATIONS
Automatic Test Equipment
Semiconductor Test Systems
Board Test Systems
Instrumentation and Characterization Equipment

## PRODUCT DESCRIPTION

The AD53522 is a complete, high-speed, single-chip solution that performs the pin electronics functions of driver, comparator, and active load (DCL) for ATE applications. In addition, the driver contains a dynamic clamp function and the active load contains an integrated Schottky diode bridge.
The driver is a proprietary design that features three active states: Data High Mode, Data Low Mode, and Term Mode, as well as an Inhibit State. In conjunction with the integrated dynamic clamp this facilitates the implementation of a high-speed active termination. The output voltage range is -0.5 V to +6.5 V to accommodate a wide variety of test devices.
The dual comparator, with an input range equal to the driver output range, features PECL compatible outputs. Signal tracking capability is in the range of $3 \mathrm{~V} / \mathrm{ns}$.
The active load can be set for up to 40 mA load current. $\mathrm{I}_{\mathrm{OH}}$, $\mathrm{I}_{\mathrm{OL}}$, and the buffered VCOM are independently adjustable. On-board Schottky diodes provide high-speed switching and low capacitance.
Also included on the chip is an on-board temperature sensor that gives an indication of the silicon surface temperature of the DCL. This information can be used to measure $\theta_{\mathrm{JC}}$ and $\theta_{\mathrm{JA}}$

## FUNCTIONAL BLOCK DIAGRAM


or flag an alarm if proper cooling is lost. Output from the sensor is a current sink that is proportional to absolute temperature. The gain is trimmed to a nominal value of $1.0 \mu \mathrm{~A} / \mathrm{k} \Omega$. As an example, the output current can be sensed by using a $10 \mathrm{k} \Omega$ resistor connected from 10 V to the THERM (I $\mathrm{I}_{\mathrm{OUT}}$ ) pin. A voltage drop across the resistor will be developed that equals: $10 \mathrm{k} \Omega \times 1 \mu \mathrm{~A} / \mathrm{k} \Omega=10 \mu \mathrm{~V} / \mathrm{k} \Omega=2.98 \mathrm{~V}$ at room temperature.

REV. 0
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## AD53522-SPECIFICATIONS

DRIVER ${ }^{1}$
$\left(T_{J}=85^{\circ} \mathrm{C} \pm 5^{\circ} \mathrm{C},+\mathrm{V}_{S}=+10.5 \mathrm{~V} \pm 1 \%,-\mathrm{V}_{S}=-4.5 \mathrm{~V} \pm 1 \%, \mathrm{VCCO}=3.3 \mathrm{~V}\right.$ unless otherwise noted. $)$

| Spec <br> No. | Parameter | Conditions | Min | Typ ${ }^{2}$ | Max | Unit | $\begin{aligned} & \text { Spec }^{3} \\ & \text { Perf } \end{aligned}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 2 3 | DIFFERENTIAL INPUT CHARA (DATA to DATAb, IOD to IODb, RLD to RLDb) <br> Voltage Range <br> Differential Voltage with <br> LVPECL levels <br> Bias Current | TERISTICS <br> Note: Inputs are from Same Logic Type Family Note: AC Tests Performed $\mathrm{V}_{\mathrm{IN}}=1.5 \mathrm{~V}, 2.5 \mathrm{~V}$ | $\begin{aligned} & 0 \\ & \pm 400 \\ & -250 \end{aligned}$ | $\pm 600$ | $\begin{aligned} & +3.3 \\ & \pm 1000 \\ & +250 \end{aligned}$ | V <br> mV <br> $\mu \mathrm{A}$ | N <br> P <br> P |
| 4 | REFERENCE INPUTS Bias Currents | Max Value Measured During Linearity Tests | -50 |  | +50 | $\mu \mathrm{A}$ | P |
| 10 | OUTPUT CHARACTERISTICS <br> Logic High Range | $\begin{aligned} & \text { Data }=\mathrm{H}, \mathrm{VH}=-0.4 \mathrm{~V} \text { to }+6.5 \mathrm{~V} \text {, } \\ & \mathrm{Vl}=-0.5 \mathrm{~V}(\mathrm{VT}=0 \mathrm{~V}, \mathrm{VH} \text { meets } \end{aligned}$ | -0.4 |  | +6.5 | V | P |
| 11 | Logic Low Range | test 20, 21 , and 22 specs) <br> Data $=\mathrm{L}, \mathrm{VL}=-0.5 \mathrm{~V}$ to +6.4 V , <br> $\mathrm{VH}=6.5 \mathrm{~V}(\mathrm{VT}=0 \mathrm{~V}, \mathrm{VL}$ meets | $-0.5$ |  | +6.4 | V | P |
| 12 | Amplitude [VH-VL] | $\begin{aligned} & \mathrm{VL}=-0.05 \mathrm{~V}, \mathrm{VH}=+0.05 \mathrm{~V}, \\ & \mathrm{VT}=0 \mathrm{~V} \text { and } \mathrm{VL}=-0.5 \mathrm{~V}, \\ & \mathrm{VH}=+6.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V} \end{aligned}$ | +0.1 |  | +7.0 | V | P |
| 20 | ABSOLUTE ACCURACY <br> VH Offset | $\begin{aligned} & \text { Data }=\mathrm{H}, \mathrm{VH}=0 \mathrm{~V}, \mathrm{VL}=-0.5 \mathrm{~V}, \\ & \mathrm{VT}=+3 \mathrm{~V} \end{aligned}$ | -50 |  | +50 | mV | P |
| 21 | VH Gain Error | $\begin{aligned} & \text { Data }=\mathrm{H}, \mathrm{VH}=-0.4 \mathrm{~V} \text { to }+6.5 \mathrm{~V}, \\ & \mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=+3 \mathrm{~V} \end{aligned}$ | -0.3 |  | +0.3 | \% of VH | P |
| 22 | Linearity Error | $\begin{aligned} & \text { Data }=\mathrm{H}, \mathrm{VH}=-0.4 \mathrm{~V} \text { to }+6.5 \mathrm{~V}, \\ & \mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=+3 \mathrm{~V} \end{aligned}$ | -5 |  | +5 | mV | P |
| 30 | VL Offset | $\begin{aligned} & \text { Data }=\mathrm{L}, \mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=6.5 \mathrm{~V}, \\ & \mathrm{VT}=3 \mathrm{~V} \end{aligned}$ | -50 |  | +50 | mV | P |
| 31 | VL Gain Error | $\begin{aligned} & \text { Data }=\mathrm{L}, \mathrm{VL}=-0.5 \mathrm{~V} \text { to }+6.4 \mathrm{~V}, \\ & \mathrm{VH}=+6.5 \mathrm{~V}, \mathrm{VT}=+3 \mathrm{~V} \end{aligned}$ | -0.3 |  | +0.3 | \% of VL | P |
| 32 | Linearity Error | $\begin{aligned} & \text { Data }=\mathrm{L}, \mathrm{VL}=-0.5 \mathrm{~V} \text { to }+6.4 \mathrm{~V}, \\ & \mathrm{VH}=+6.5 \mathrm{~V}, \mathrm{VT}=+3 \mathrm{~V} \end{aligned}$ | -5 |  | +5 | $\mathrm{mV}$ | P |
| 33 | Offset Temperature Coefficient | $\mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}$ |  | 0.5 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ | N |
| 40 | OUTPUT RESISTANCE $\mathrm{VH}=-0.3 \mathrm{~V}$ | $\begin{aligned} & \mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{OUT}}=+1, \\ & +30 \mathrm{~mA} \end{aligned}$ | +46 |  | +50 | $\Omega$ | N |
| 41 | $\mathrm{VH}=+6.5 \mathrm{~V}$ | $\begin{aligned} & \mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{OUT}}=-1, \\ & -30 \mathrm{~mA} \end{aligned}$ | +46 |  | +50 | $\Omega$ | P |
| 42 | $\mathrm{VL}=-0.5 \mathrm{~V}$ | $\begin{aligned} & \mathrm{VH}=+6.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{OUT}}=+1, \\ & +30 \mathrm{~mA} \end{aligned}$ | +46 |  | +50 | $\Omega$ | P |
| 43 | $\mathrm{VL}=+6.4 \mathrm{~V}$ | $\begin{aligned} & \mathrm{VH}=+6.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{I}_{\text {OUT }}=-1, \\ & -30 \mathrm{~mA} \end{aligned}$ | +46 |  | +50 | $\Omega$ | N |
| 44 | $\mathrm{VH}=+2.5 \mathrm{~V}$ | $\mathrm{VL}=0 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{I}_{\text {OUT }}=-30 \mathrm{~mA}$ <br> (Trim Point) |  | +47.5 |  | $\Omega$ | P |
| 50 | Dynamic Current Limit | $\begin{aligned} & \mathrm{Cbyp}=39 \mathrm{nF}, \mathrm{VH}=+6.5 \mathrm{~V}, \\ & \mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V} \end{aligned}$ | $+100$ |  |  | mA | N |
| 51 | Static Current Limit | Output to $-0.5 \mathrm{~V}, \mathrm{VH}=+6.5 \mathrm{~V}$, $\mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{DATA}=\mathrm{H}$ | $-120$ |  | -60 | mA | P |
| 52 | Static Current Limit | Output to $+6.5 \mathrm{~V}, \mathrm{VH}=+6.5 \mathrm{~V}$, $\mathrm{VL}=-0.5 \mathrm{~V}, \mathrm{VT}=0 \mathrm{~V}, \mathrm{DATA}=\mathrm{L}$ | +60 |  | +120 | mA | P |


| AD53522 |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Spec <br> No. | Parameter | Conditions | Min | Typ ${ }^{2}$ | Max | Unit | $\begin{aligned} & \text { Spec }^{3} \\ & \text { Perf } \end{aligned}$ |
| 60 | VTERM <br> Voltage Range | TERM MODE, $\mathrm{VTERM}=-0.3 \mathrm{~V}$ to $+6.3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=+3 \mathrm{~V}$ (VTERM meets test 61, 62, and 63 specs) | -0.3 |  | +6.3 | V | P |
| 61 | VTERM Offset | TERM MODE, VTERM $=0 \mathrm{~V}$, $\mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=3 \mathrm{~V}$ | -50 |  | +50 | $\mathrm{mV}$ | P |
| 62 | VTERM Gain Error | $\begin{aligned} & \text { TERM MODE, VTERM }=-0.3 \mathrm{~V} \\ & \text { to }+6.3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=+3 \mathrm{~V} \end{aligned}$ | -0.3 |  | +0.3 | $\%$ of $\mathrm{V}_{\text {SET }}$ | P |
| 63 | VTERM Linearity Error | TERM MODE, VTERM $=-0.3 \mathrm{~V}$ to $+6.3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=+3 \mathrm{~V}$ | -5 |  | +5 | $\mathrm{mV}$ | P |
| 64 | Offset Temperature Coefficient | $\mathrm{VTERM}=0 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=3 \mathrm{~V}$ |  | +0.5 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ | N |
| 70 | Output Resistance DC | $\mathrm{I}_{\text {OUT }}=+30 \mathrm{~mA},-1 \mathrm{~mA}, \mathrm{VTERM}=$ $-0.3 \mathrm{~V}, \mathrm{VH}=3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}$ $\mathrm{I}_{\text {OUT }}=-30 \mathrm{~mA},+1 \mathrm{~mA}, \mathrm{VTERM}=$ $+6.3 \mathrm{~V}, \mathrm{VH}=3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}$ $\mathrm{I}_{\text {OUT }}= \pm 30 \mathrm{~mA}, \pm 1 \mathrm{~mA}, \mathrm{VTERM}=$ $+2.5 \mathrm{~V}, \mathrm{VH}=3 \mathrm{~V}, \mathrm{VL}=0 \mathrm{~V}$ | +46 |  | +50 | $\Omega$ | N <br> N <br> P |
| 72 | PSRR, Drive, or TERM Mode | $+\mathrm{V}_{\mathrm{S}},-\mathrm{V}_{\mathrm{S}} \pm 1 \%$ |  | 17.8 |  | $\mathrm{mV} / \mathrm{V}$ | N |
| 73 | Static Current Limit | Output to -0.3 V, VTERM $=+6.3 \mathrm{~V}$ | -120 |  | -60 | mA | P |
| 74 | Static Current Limit | Output to +6.3 V, VTERM $=-0.3 \mathrm{~V}$ | +60 |  | +120 | mA | P |
| 80 | DYNAMIC PERFORMANCE, DRIVE (VH and VL) |  |  |  |  |  |  |
|  | Propagation Delay Time | Measured at $50 \%, \mathrm{VL}=0 \mathrm{~V}$, $\mathrm{VH}=3 \mathrm{~V}$, into $500 \Omega$ | 1.25 | 1.4 | 1.55 |  | P |
| 81 | Propagation Delay T.C. | Measured at $50 \%, \mathrm{VL}=0 \mathrm{~V}$, $\mathrm{VH}=3 \mathrm{~V}$, into $500 \Omega$ |  | 2 | 200 | ps $/{ }^{\circ} \mathrm{C}$ | N |
| 82 | Delay Matching, Edge-to-Edge | Measured at $50 \%, \mathrm{VL}=0 \mathrm{~V}$, $\mathrm{VH}=3 \mathrm{~V}$, into $500 \Omega$ |  |  |  | ps | P |
| 90 | RISE AND FALL TIMES 200 mV Swing | $\begin{aligned} & \text { Measured } 20 \%-80 \%, \mathrm{VL}=-0.1 \mathrm{~V}, \\ & \mathrm{VH}=+0.1 \mathrm{~V} \text {, into } 50 \Omega \end{aligned}$ | 0.25 |  |  | ns | N |
| 91 | 1 V Swing | Measured $20 \%-80 \%$, VL $=0 \mathrm{~V}$, $\mathrm{VH}=1 \mathrm{~V}$, into $50 \Omega$ | 0.3 |  |  | ns | N |
| 92 | 3 V Swing | $\text { Measured } 10 \%-90 \%, \mathrm{VL}=0 \mathrm{~V} \text {, }$ $\mathrm{VH}=3 \mathrm{~V} \text {, into } 50 \Omega$ | 0.8 |  |  | ns | N |
| 93 | 3 V Swing | Measured $10 \%-90 \%$, $\mathrm{VL}=0 \mathrm{~V}$, $\mathrm{VH}=3 \mathrm{~V}$, into $500 \Omega$ | 0.450 | 0.8 |  | ns | N |
| 93A | 3 V Swing | Measured $20 \%-80 \%$, VL $=0 \mathrm{~V}$, $\mathrm{VH}=3 \mathrm{~V}$, into $500 \Omega$ |  | 0.560 | 0.670 | ns | P |
| 94 | 5 V Swing | Measured $10 \%-90 \%$, $\mathrm{VL}=0 \mathrm{~V}$, $\mathrm{VH}=5 \mathrm{~V}$, into $500 \Omega$ |  | 1.2 | 1.5 | ns | N |
| $\begin{aligned} & 100 \\ & 101 \\ & 102 \\ & 110 \end{aligned}$ | RISE AND FALL TIME TEMPERATURE COEFFICIENT |  |  |  |  |  |  |
|  | 1 V Swing | (per test 91) |  | $\pm 2$ |  | ps $/{ }^{\circ} \mathrm{C}$ | N |
|  | 3 V Swing | (per test 92) |  | $\pm 2$ |  | ps $/{ }^{\circ} \mathrm{C}$ | N |
|  | 5 V Swing | (per test 94) |  | $\pm 4$ |  | ps/ ${ }^{\circ} \mathrm{C}$ | N |
|  | Overshoot and Preshoot | VL, VH $=-0.1 \mathrm{~V},+0.1 \mathrm{~V}$, <br> Driver Terminated into $50 \Omega$ |  |  | $0+50$ | $\begin{aligned} & \% \text { of Step } \\ & +\mathrm{mV} \end{aligned}$ | N |
|  |  | $\mathrm{VL}, \mathrm{VH}=0.0 \mathrm{~V}, 3 \mathrm{~V}$, <br> Driver Terminated into $50 \Omega$ | $-6.0-50$ |  | $+6.0+50$ | $\begin{aligned} & \% \text { of Step } \\ & +\mathrm{mV} \end{aligned}$ | N |
| 120 121 | SETTING TIME <br> to 15 mV <br> to 4 mV | $\mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=0.5 \mathrm{~V}$, Driver <br> Terminated into $50 \Omega$ $\mathrm{VL}=0 \mathrm{~V}, \mathrm{VH}=0.5 \mathrm{~V}$ |  | 50 10 |  | ns | N N |

## (continued)

DRIVER ${ }^{1}$
(continued)


COMPARATOR ${ }^{1}$


## (continued)

active Load ${ }^{1}$

| Spec <br> No. | Parameter | Conditions | Min | Typ ${ }^{2}$ | Max | Unit | $\begin{aligned} & \text { Spec }^{3} \\ & \text { Perf } \end{aligned}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | BIAS CURRENT | $\mathrm{VIOH}=0 \mathrm{~V}, 4 \mathrm{~V}$ |  |  |  |  |  |
| 303 | VIOL Current Program Range, IOL $=0 \mathrm{~mA}$ to 40 mA | VDUT $=-0.5 \mathrm{~V},+5.2 \mathrm{~V}$ | 0 |  | 4.0 | V | P |
| 304 | IOH, VIOL Input | $\mathrm{VIOL}=0 \mathrm{~V}, 4 \mathrm{~V}$ and | -300 | +300 |  | $\mu \mathrm{A}$ | P |
| 305 | IOXRTN Range | $\begin{aligned} & \mathrm{IOL}=+40 \mathrm{~mA}, \mathrm{IOH}=-40 \mathrm{~mA} \\ & \text { VDUT }=-0.5 \mathrm{~V},+6.5 \mathrm{~V} \end{aligned}$ |  | -0.5, |  | V | N |
| 310 | VDUT Range | $\begin{aligned} & \mathrm{IOL}=+40 \mathrm{~mA}, \mathrm{IOH}=-40 \mathrm{~mA}, \\ & \|\mathrm{VDUT}-\mathrm{VCOM}\|>1.3 \mathrm{~V} \end{aligned}$ | -0.5 |  | +6.5 | V | P |
| 311 | VDUT Range, $\mathrm{IOH}=$ 0 mA to -40 mA | VDUT - VCOM $>1.3 \mathrm{~V}$ | 0.8 |  | 6.5 | V | P |
| 312 | VDUT Range, $\mathrm{IOL}=$ <br> 0 mA to +40 mA | VCOM - VDUT > 1.3 V | -0.5 |  | +5.2 | V | P |
| 320 | OUTPUT CHARACTERISTICS Accuracy <br> Gain Error, Load Current, Normal Range Calculated at 1 mA and 40 mA points ${ }^{2}$ | IOL, $\mathrm{IOH}=25 \mu \mathrm{~A}-40 \mathrm{~mA}$, $\mathrm{VCOM}=0 \mathrm{~V}, \mathrm{VDUT}= \pm 2 \mathrm{~V}$ and $\mathrm{IOL}=25 \mu \mathrm{~A}$ to $40 \mathrm{~mA}, \mathrm{VCOM}=$ +6.5 V , VDUT $=+5.2 \mathrm{~V}$ and $\mathrm{IOH}=25 \mu \mathrm{~A}$ to $40 \mathrm{~mA}, \mathrm{VCOM}=$ $-0.5 \mathrm{~V}, \mathrm{VDUT}=+0.8 \mathrm{~V}$ | -0.35 |  | +0.35 | $\% \mathrm{I}_{\mathrm{SET}}$ | P |
| 321 | Load Offset | Calculated from Intercept of 1 mA and 40 mA Points | -300 |  | +300 |  |  |
| $\begin{aligned} & 322 \\ & 323 \end{aligned}$ | Load Nonlinearity Output Current Temperature | IOL, IOH from $25 \mu \mathrm{~A}$ to 40 mA Measured at $\mathrm{IOH}, \mathrm{IOL}=200 \mu \mathrm{~A}$ | -80 | $< \pm 3$ | +80 | $\mu \mathrm{A}$ <br> $\mu \mathrm{A} /{ }^{\circ} \mathrm{C}$ | $\begin{aligned} & \mathrm{P} \\ & \mathrm{~N} \end{aligned}$ |
| 324 | COEFFICIENT <br> IOH Extended Range | Driver Inhibited, $\mathrm{IOH}=1 \mathrm{~mA}$, Change in IOH from VTT = 0 V to $\mathrm{VTT}=-1.0 \mathrm{~V}$ | 2 |  |  | \% | P |
|  | VCOM BUFFER |  |  |  |  |  |  |
| 330 331 | VCOM Buffer Bias Current | V $\mathrm{VCOL}, \mathrm{MH}=0 \mathrm{~V}$ | -50 |  | +50 | mV | P |
| 332 | VCOM Buffer Gain Error | IOL, $\mathrm{IOH}=40 \mathrm{~mA}, \mathrm{VCOM}=$ |  |  | +4 | $\begin{aligned} & \mu \mathrm{A} \\ & \% \end{aligned}$ | $\begin{aligned} & P \\ & P \end{aligned}$ |
| 333 | VCOM Buffer Linearity Error | $\begin{aligned} & -0.5 \mathrm{~V} \text { to }+6.5 \mathrm{~V} \\ & \mathrm{IOL}, \mathrm{IOH}=40 \mathrm{~mA}, \mathrm{VCOMI}= \\ & -0.5 \mathrm{~V} \text { to }+6.5 \mathrm{~V} \end{aligned}$ | $-10$ |  | $+10$ | $\mathrm{mV}$ | P |
|  | DYNAMIC PERFORMANCE |  |  |  |  |  |  |
| 340 | Propagation Delay <br> $\pm \mathrm{I}_{\text {MAX }}$ to INHIBIT | $\begin{aligned} & \mathrm{VTT}=+2 \mathrm{~V}, \mathrm{VCOM}=+4 / 0 \mathrm{~V}, \\ & \mathrm{IOL}=+20 \mathrm{~mA}, \mathrm{IOH}=-20 \mathrm{~mA} \end{aligned}$ |  | 1.3 | 2.0 | ns | P |
| 341 | INHIBIT to $\pm \mathrm{I}_{\text {MAX }}$ | $\begin{aligned} & \mathrm{VTT}=+2 \mathrm{~V}, \mathrm{VCOM}=+4 / 0 \mathrm{~V}, \\ & \mathrm{IOL}=+20 \mathrm{~mA}, \mathrm{IOH}=-20 \mathrm{~mA} \end{aligned}$ | 1.2 | 1.8 | 2.4 | ns | P |
| 342 | Propagation Delay Matching | $\begin{aligned} & \text { Matching = (Test } 340 \text { Value) } \\ & \text { (Test } 341 \text { Value) } \end{aligned}$ | -1.0 |  | +1.0 | ns | P |
| 350 | I/O Spike | $\begin{aligned} & \mathrm{VCOM}=0 \mathrm{~V}, \mathrm{IOL}=+20 \mathrm{~mA}, \\ & \mathrm{IOH}=-20 \mathrm{~mA} \end{aligned}$ |  | 250 |  | mV | N |
| 360 | Settling Time to 15 mV | $\begin{aligned} & \mathrm{IOL}=+20 \mathrm{~mA}, \mathrm{IOH}=-20 \mathrm{~mA}, \\ & 50 \Omega \text { Load, to } \pm 15 \mathrm{mV} \end{aligned}$ |  | 50 |  | ns | N |
| 361 | Settling Time to 4 mV | $\begin{aligned} & \mathrm{IOL}=+20 \mathrm{~mA}, \mathrm{IOH}=-20 \mathrm{~mA}, \\ & 50 \Omega \text { Load, to } \pm 4 \mathrm{mV} \end{aligned}$ |  | 10 |  | $\mu \mathrm{s}$ | N |

## DYNAMIC CLAMP PART

| Spec <br> No. | Parameter | Conditions | Min | Typ ${ }^{2}$ | Max | Unit | Spec $^{3}$ Perf |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 400 | Input Voltage VCH |  | 2 |  | 7.5 | V | P |
| 401 | Input Voltage VCL |  | -1.5 |  | +4 | V | P |
| 402 | Input Bias Current VCH/VCL | Over range spec \#401, 402 | -250 |  | +250 | $\mu \mathrm{A}$ | P |
| 410 | VCH, VCL Offset Error | $\mathrm{I}_{\mathrm{TEST}}=1 \mathrm{~mA}$ | -250 |  | +250 | mV | P |
| 411 | VCH, VCL Gain Error | $\mathrm{I}_{\mathrm{TEST}}=1 \mathrm{~mA}$ | 0.96 |  | 1.01 | V/V | P |
| 420 | Static Current Capability |  | 50 |  | 75 | mA | N |
| 430 | Incremental Resistance | 11 mA to 21 mA | 45 | 48 | 52 | $\Omega$ | P |
| 440 | VCHP, VCLP Protection Diodes Vf @ $500 \mu$ |  | 0.52 |  | 0.64 | V | P |
| 441 | Protection Diodes Max Current | For information only |  |  | 2 | mA | N |
|  | TOTAL FUNCTION POWER DOW |  |  |  |  |  |  |
| 500 | PWRD Input Voltage |  | 0 |  | 5 | V | P |
| 501 | PWRD Bias Current | PWRD trip point $1.4 \mathrm{~V} \pm 0.15 \mathrm{~V}$ | -250 |  | +250 | $\mu \mathrm{A}$ | P |
| 503 | Power-Down Supply Reduction | $\mathrm{VIOH}=0 \mathrm{~V}, \mathrm{VIOL}=0 \mathrm{~V}$ | 35 |  | 60 | \% | P |
| 504 | Power-Down Output |  |  |  |  |  |  |
|  | Leakage Current | $\begin{aligned} & \mathrm{VIOH}=0 \mathrm{~V}, \mathrm{VIOL}=0 \mathrm{~V} \\ & \mathrm{~V}_{\text {OUT }}=-0.5 \mathrm{~V} \text { to }+5.5 \mathrm{~V} \end{aligned}$ | -20 |  | +20 | nA | P |
| 505 | Power-Down Output Leakage Current | $\begin{aligned} & \mathrm{VIOH}=0 \mathrm{~V}, \mathrm{VIOL}=0 \mathrm{~V}, \\ & \mathrm{~V}_{\text {OUT }}=5.5 \mathrm{~V} \text { to } 6.5 \mathrm{~V} \end{aligned}$ | -500 |  | +500 | nA | P |
| 600 | Output Leakage Current, $\mathrm{V}_{\text {OUT }}=-0.5 \mathrm{~V} \text { to }+6.5 \mathrm{~V}$ |  | -1 |  | +1 | $\mu \mathrm{A}$ | P |
| 601 | Output Leakage Current, $\mathrm{V}_{\text {Out }}=0 \mathrm{~V}$ to 5 V |  | -500 |  | +500 | nA | P |
| 602 | Output Leakage Current, $\mathrm{V}_{\text {OUT }}=-1 \mathrm{~V}$ |  | -5 |  | +5 | $\mu \mathrm{A}$ | P |
| 605 | Output Capacitance | Driver and Load INHIBITED |  | 9.2 |  | pF | N |
| 606 | Output Capacitance Term | Driver VTERM $=0 \mathrm{~V}$, Load INHIBITED |  | 2.5 |  | pF | N |
|  | POWER SUPPLIES |  |  |  |  |  |  |
| 610 | Total Supply Range |  |  | 15 |  | V | N |
| 620 | Positive Supply, VCC |  |  | +10.5 |  | V | N |
| 630 | Negative Supply, VEE |  |  | -4.5 |  | $\mathrm{V}$ | $\mathrm{N}$ |
| 640 | Positive Supply Current, VCC | $\begin{aligned} & \text { Driver }=\text { Inhibit, } \mathrm{I}_{\text {LOAD }} \text { program }= \\ & 40 \mathrm{~mA} \text {, Load }=\text { Active } \end{aligned}$ |  | 465 | 570 | mA | P |
| 650 | Negative Supply Current, VEE | $\begin{aligned} & \text { Driver }=\text { Inhibit, } \mathrm{I}_{\text {LOAD }} \text { program }= \\ & 40 \mathrm{~mA} \text {, Load }=\text { Active } \end{aligned}$ |  | 475 | 600 | mA | P |
| 651 | Comparator Supply Current Overhead, VCCO | Driver $=$ Inhibit, $\mathrm{I}_{\text {LOAD }}$ program $=$ 40 mA , Load $=$ Active ( $\mathrm{I}_{\mathrm{VCCO}}-$ (comparator logic output currents)) |  |  | 45 | mA | P |
| 660 | Total Power Dissipation | $\begin{aligned} & \text { Driver }=\text { Inhibit, } \mathrm{I}_{\text {LOAD }} \text { program }= \\ & 40 \mathrm{~mA} \text {, Load }=\text { Active } \end{aligned}$ |  | 7.2 | 7.9 | W | P |
| 661 | Total Power Dissipation | $\begin{aligned} & \text { Driver }=\text { Inhibit, } \mathrm{I}_{\text {LOAD }} \text { program }= \\ & 0 \mathrm{~mA} \end{aligned}$ |  | 5.2 | 5.9 | W | P |
| 700 | Temperature Sensor Gain Factor | $\mathrm{R}_{\text {LOAD }}=10 \mathrm{k} \Omega, \mathrm{V}_{\text {SOURCE }}=10.5 \mathrm{~V}$ |  | 1 |  | $\mu \mathrm{A} / \mathrm{K}$ | N |

NOTES
${ }^{1}$ All temperature coefficients are measured at $\mathrm{T}_{\mathrm{J}}=75^{\circ} \mathrm{C}-95^{\circ} \mathrm{C}$. In test figures, voltmeter loading is $1 \mathrm{M} \Omega$ or greater, scope probe loading is $100 \mathrm{k} \Omega$ in parallel with 0.6 pF .
${ }^{2}$ Typical Values are not tested or guaranteed. Nominal values are generated from design or simulation analyses and/or limited bench evaluations and are not tested or guaranteed.
${ }^{3}$ Spec Perf: $\mathrm{N}=$ Nominal, $\mathrm{O}=$ Operating Condition, $\mathrm{T}=$ Typical, $\mathrm{P}=$ Production, Max Min
${ }^{4}$ VTERM Linearity over the following condition: VL $-6 \mathrm{~V}<\mathrm{VTERM}<\mathrm{VH}+6 \mathrm{~V}$
${ }^{5}$ All ac input values are referred to the source end of transmission line input.
${ }^{6}$ All ac tests are performed with Driver in VTERM mode except where noted.
${ }^{7}$ Rise time is calculated SQRT ( $(\operatorname{comp}$ out rt$\left.){ }^{* *} 2-(\mathrm{comp} \mathrm{in} \mathrm{rt}){ }^{* *} 2\right)$
Specifications are subject to change without notice.
ABSOLUTE MAXIMUM RATINGS ${ }^{1}$POWER SUPPLY VOLTAGE
$V_{C C}$ to GND ..... 11.3 V
$V_{E E}$ to GND ..... -7 V
$\mathrm{V}_{\mathrm{CC}}$ to $\mathrm{V}_{\mathrm{EE}}$ ..... 18 V
VCCO to GND ..... 5.5 V
PWRGND, DRGND, GND_ROT, or HQGND ..... $\pm 0.4 \mathrm{~V}$OUTPUTS
Vout Short Circuit Duration ..... Indefinite ${ }^{2}$
$V_{\text {Out }}$, Inhibit Mode ..... $+8.5 \mathrm{~V},-2 \mathrm{~V}$
$V_{\text {OUt }}$, Inhibit Mode
VHDCPL . . . . . . . . . Do Not Connect Except for Cap to $\mathrm{V}_{\mathrm{CC}}$
VLDCPL Do Not Connect Except for Cap to $\mathrm{V}_{\mathrm{EE}}$$\mathrm{QH}, \mathrm{QHb}, \mathrm{QL}, \mathrm{QLB}$ Maximum $\mathrm{I}_{\text {OUT }}$ :
Continuous ..... 50 mA
Surge ..... 100 mA
THERM ..... $11 \mathrm{~V}, 0 \mathrm{~V}$
Driver output capacitance, maximum ..... 10 pF
INPUTS
DATA, DATAb, IOD, IODb, RLD, RLDB ..$\left(\mathrm{V}_{\mathrm{CCO}}+1.5 \mathrm{~V}\right.$,$\left.\mathrm{V}_{\mathrm{CCO}}-4.5 \mathrm{~V}\right)$
INHL, INHLb, CMPD ..... -0.4 V to +5.5 V
PWRD -0.4 V to +4.5 V
DATA to DATAb, IOD to IODb, RLD to RLDB ..... $\pm 3$ V
INHL to INHLb ..... $\pm 6 \mathrm{~V}$
VH, VL, VTERM to GND (Rseries < $500 \Omega$ ) . +7.5 V, -1.1 VVH to VL . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . +8 V, -3.5 V
(VH - VTERM) and (VTERM - VL) . . . . . . . . . . . . . . . $\pm 8$ V
Reflection Clamps High/Low ..... $+8.5 \mathrm{~V},-2 \mathrm{~V}$
Protection Clamp Breakdown Voltage ..... 12 V
Protection Clamps Current ..... $\pm 5 \mathrm{~mA}$
Vout to HCOMP or LCOMP ..... $\pm 7.8 \mathrm{~V}$
ENVIRONMENTAL
Operating Temperature (Junction) ..... $175^{\circ} \mathrm{C}$
Storage Temperature . . . . . . . . . . . . . . . . . . $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$
Lead Temperature (Soldering, 10 sec$)^{3}$ ..... $260^{\circ} \mathrm{C}$
NOTES
${ }^{1}$ Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Absolute maximum limits apply individually, not in combination. Exposure to absolute maximum rating conditions for extended periods may affect device reliability
${ }^{2}$ Output short circuit protection is guaranteed as long as proper heat sinking is employed to ensure compliance with the operating temperature limits.
${ }^{3}$ To ensure lead coplanarity ( $\pm 0.002$ inches) and solderability, handling with bare hands should be avoided and the device should be stored in environments at $24^{\circ} \mathrm{C}$ $\pm 5^{\circ} \mathrm{C}\left(75^{\circ} \mathrm{F} \pm 10^{\circ} \mathrm{F}\right)$ with relative humidity not to exceed $65 \%$.

ORDERING GUIDE

| Model | Temperature <br> Range | Package <br> Description | Package <br> Option |
| :--- | :--- | :--- | :--- |
| AD53522JSQ | $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | 100-Lead LQFP-EDQUAD <br> with Integral Heat Slug | SQ-100 |

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD53522 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.


Table I. Driver Truth Table

| DATA | DATAb | IOD | IODb | RLD | RLDb | Output <br> State |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 0 | 1 | 1 | 0 | X | X | VL |
| 1 | 0 | 1 | 0 | X | X | VH |
| X | X | 0 | 1 | 0 | 1 | INH and |
| X | X | 0 | 1 | 1 | 0 | CLAMP |

Table II. Comparator Truth Table

| V $_{\text {out }}$ | Output States |  |  |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- |
|  | QHb | QL | QLb |  |  |
| > HCOMP | Q LCOMP | 1 | 0 | 1 | 0 |
| > HCOMP | < LCOMP | 1 | 0 | 0 | 1 |
| < HCOMP | > LCOMP | 0 | 1 | 1 | 0 |
| < HCOMP | < LCOMP | 0 | 1 | 0 | 1 |

Table III. Active Load Truth Table

|  |  |  | Output States (including diode bridge) |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- |
| VDUT | INHL | INHLb | IOH | IOL | I(VOUT) |
| $<$ VCOM | 0 | 1 | V(IOHC) $\times+10 \mathrm{~mA}$ | V(IOLC) $\times-10 \mathrm{~mA}$ | IOL |
| $>$ VCOM | 0 | 1 | V(IOHC) $\times+10 \mathrm{~mA}$ | V(IOLC) $\times-10 \mathrm{~mA}$ | IOH |
| X | 1 | 0 | 0 | 0 | 0 |
| $-8-$ |  |  |  |  |  |

## PIN CONFIGURATION



NOTE
DIE IS MOUNTED TO THE BACK OF THE HEAT SLUG.
THE PACKAGE IS MOUNTED TO THE BOARD, HEAT SLUG UP.

## PIN FUNCTION DESCRIPTIONS

| Pin Number | Mnemonic | Description |
| :--- | :--- | :--- |
| 1 | PROT_HI1 | Channel 1, output voltage sensing diode |
| 2 | IOXRTN1 | Current return path for the active load for channel 1. Typically connected to a power ground. |
| 3 | VCH1 | Analog input voltage that sets the reflection clamp high level of channel 1 |
| 4 | VCL1 | Analog input voltage that sets the reflection clamp low level of channel 1 |
| 5 | VHDCPL1 | Internal supply decoupling for the driver output stage of channel 1. This pin needs to be <br> connected to $\mathrm{V}_{\mathrm{CC}}$ through a 39 nF (minimum) capacitor. |
| 6 | OUT1 | Input/output for the driver, window comparator, reflection clamp, and the active load of channel 1 |
| 7 | VLDCPL1 | Internal supply decoupling for the driver output stage of channel 1. This pin needs to be <br> connected to $\mathrm{V}_{\mathrm{EE}}$ through a 39 nF (minimum) capacitor. |
| 8 | PWRGND | Power ground <br> 9 |


| Pin Number | Mnemonic | Description |
| :---: | :---: | :---: |
| 11 | PWRGND | Power ground |
| 12 | PWRGND | Power ground |
| 13 | GND_ROT | Analog ground |
| 14 | PWRGND | Power ground |
| 15 | PWRGND | Power ground |
| 16 | DR_GND | Analog ground |
| 17 | PWRGND | Power ground |
| 18 | PWRGND | Power ground |
| 19 | VLDCPL2 | Internal supply decoupling for the driver output stage of channel 2 . This pin needs to be connected to $\mathrm{V}_{\mathrm{EE}}$ through a 39 nF (minimum) capacitor. |
| 20 | OUT2 | Input/output for the driver, window comparator, reflection clamp, and the active load of channel 2 |
| 21 | VHDCPL2 | Internal supply decoupling for the driver output stage of channel 2 . This pin needs to be connected to $\mathrm{V}_{\mathrm{CC}}$ through a 39 nF (minimum) capacitor. |
| 22 | VCL2 | Analog input voltage that sets the reflection clamp high level of channel 2 |
| 23 | VCH2 | Analog input voltage that sets the reflection clamp high level of channel 2 |
| 24 | IOXRTN2 | Current return path for the active load for channel 2. Typically connected to a power ground. |
| 25 | PROT_HI2 | Channel 2, output voltage sensing diode |
| 26 | PROT_LO2 | Channel 2, output voltage sensing diode |
| 27 | PWRGND | Power ground |
| 28 | PWRGND | Power ground |
| 29 | VCOM_S2 | Analog output voltage that represents a buffered VCOM1 input |
| 30 | THERMSTART | Temperature sensor startup pin. Normally not connected |
| 31 | IOLC2 | Analog input voltage that programs the channel 2 active load source current |
| 32 | IOHC2 | Analog input voltage that programs the channel 2 active load sink current |
| 33 | HQGND | Clean analog ground for the active load for channel 2 |
| 34 | INHL2 | One of two complementary inputs that control the inhibit mode for the active load bridge of channel 2 |
| 35 | $\overline{\text { INHLB2 }}$ | One of two complementary inputs that control the inhibit mode for the active load bridge of channel 2 |
| 36 | $\mathrm{V}_{\text {EE }}$ | Negative supply terminal |
| 37 | $\mathrm{V}_{\text {CC }}$ | Positive supply terminal |
| 38 | PWRGND | Power ground |
| 39 | RLD2 | One of two complementary inputs that control, in conjunction with IOD2 and IODB2, the operating mode of the channel 2 driver. Refer to the Driver Truth Table for specific conditions. |
| 40 | IOD2 | One of two complementary inputs that control, in conjunction with RLD2 and RLDB2, the operating mode of the channel 2 driver. Refer to the Driver Truth Table for specific conditions. |
| 41 | $\overline{\text { IODB2 }}$ | One of two complementary inputs that control, in conjunction with RLD2 and RLDB2, the operating mode of the channel 2 driver. Refer to the Driver Truth Table for specific conditions. |
| 42 | DATA2 | One of two complementary input that determine the high and low state of the channel 2 driver. Driver output is high for DATA2 > DATAB2. Refer to the Driver Truth Table for specific conditions. |
| 43 | $\overline{\text { DATAB2 }}$ | One of two complementary input that determine the high and low state of the channel 2 driver. Driver output is high for DATA2 > DATAB2. Refer to the Driver Truth Table for specific conditions. |
| 44 | PWRGND | Power ground |
| 45 | PWRGND | Power ground |
| 46 | VCOM2 | Analog input voltage that establishes the commutation voltage for the active load diode bridge for channel 2 |
| 47 | VH2 | Analog input voltage that sets the Logic 1 level of the driver output limit for channel 2. Determines the driver output for DATA2 $>$ DATAB |


| Pin Number | Mnemonic | Description |
| :--- | :--- | :--- |
| 48 | VTERM2 | Analog input voltage that sets the termination voltage level of the channel 2 driver when in <br> VTERM mode |
| 49 | VL2 | Analog input voltage that sets the Logic 0 level of the driver output limit for channel 2 . Determines <br> the driver output for DATAB2 |
| 50 | DATA2. |  |


| Pin Number | Mnemonic | Description |
| :---: | :---: | :---: |
| 85 | $\overline{\text { IODB1 }}$ | One of two complementary inputs that control, in conjunction with RLD1 and RLDB1, the operating mode of the channel 1 driver. Refer to the Driver Truth Table for specific conditions. |
| 86 | IOD1 | One of two complementary inputs that control, in conjunction with RLD1 and RLDB1, the operating mode of the channel 1 driver. Refer to the Driver Truth Table for specific conditions. |
| 87 | RLD1 | One of two complementary inputs that controls, in conjunction with IOD1 and IODB1, the operating mode of the channel 1 driver. Refer to the Driver Truth Table for specific conditions. |
| 88 | PWRGND | Power ground |
| 89 | $\mathrm{V}_{\mathrm{CC}}$ | Positive supply terminal |
| 90 | $\mathrm{V}_{\text {EE }}$ | Negative supply terminal |
| 91 | $\overline{\text { INHLB1 }}$ | One of two complementary inputs that control the inhibit mode for the active load bridge of channel 1 |
| 92 | INHL1 | One of two complementary inputs that control the inhibit mode for the active load bridge of channel 1 |
| 93 | HQGND | Clean analog ground for the active load for channel 1 |
| 94 | IOHC1 | Analog input voltage that programs the channel 1 active load sink current |
| 95 | IOLC1 | Analog input voltage that programs the channel 1 active load source current |
| 96 | THERM | Temperature sensor output pin. A resistor ( 10 KW ) should be connected between THERM and $\mathrm{V}_{\mathrm{CC}}$. The approximate die temperature can be determined by measuring the current through the resistor. The typical scale factor is $1 \mu \mathrm{~A} / \mathrm{K}$. |
| 97 | VCOM_S1 | Analog output voltage that represents a buffered VCOM1 input |
| 98 | PWRGND | Power ground |
| 99 | PWRGND | Power ground |
| 100 | PROT_LO1 | Channel 1 output voltage sensing diode |

## OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).
100-Lead LQFP-EDQUAD (SQ-100)


